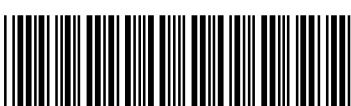


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10560907	SUGIHARA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Kim, Jay C	2815

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	43, 613, E21.372, E29.273, E27.06, E29.169, E29.242, E29.273, E21.051, E21.4, E21.372	10/30/07	J.K.

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (DERWENT), See EAST Search History	10/29/07	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	10/29/07	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	10/30/07	J.K.
EAST (DERWENT), See EAST Search History	11/5/07	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	11/5/07	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	11/12/07	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	11/13/07	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	4/11/08	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	9/4/08	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	9/8/08	J.K.
EAST (US-PGPUB; USPAT; USOCR), See EAST Search History	2/2/09	J.K.

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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